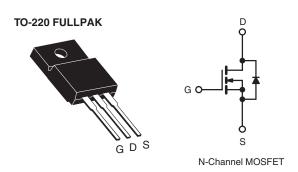


Vishay Siliconix

Power MOSFET

PRODUCT SUMMARY					
V _{DS} (V)	60				
R _{DS(on)} (Ω)	V _{GS} = 5.0 V	0.20			
Q _g (Max.) (nC)	8.4				
Q _{gs} (nC)	3.5				
Q _{gd} (nC)	6.0				
Configuration	Single				



FEATURES

- · Isolated Package
- High Voltage Isolation = 2.5 kV_{RMS} (t = 60 s; f = 60 Hz) RoHS COMPLIANT
- Sink to Lead Creepage Distance = 4.8 mm
- · Logic-Level Gate Drive
- R_{DS(on)} Specified at V_{GS} = 4 V and 5 V
- · Fast Switching
- · Ease of Paralleling
- · Lead (Pb)-free Available

DESCRIPTION

Third generation Power MOSFETs from Vishay provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

The TO-220 FULLPAK eliminates the need for additional insulating hardware in commercial-industrial applications. The molding compound used provides a high isolation capability and a low thermal resistance between the tab and external heatsink. This isolation is equivalent to using a 100 micron mica barrier with standard TO-220 product. The FULLPAK is mounted to a heatsink using a single clip or by a single screw fixing.

ORDERING INFORMATION	
Package	TO-220 FULLPAK
Lead (Pb)-free	IRLIZ14GPbF
	SiHLIZ14G-E3
SnPb	IRLIZ14G
	SiHLIZ14G

ABSOLUTE MAXIMUM RATINGS $T_C = 25 ^{\circ}C$, unless otherwise noted							
PARAMETER			SYMBOL	LIMIT	UNIT		
Drain-Source Voltage		V _{DS}	60	V			
Gate-Source Voltage			V _{GS}	± 10	v		
Continuous Drain Current	V _{GS} at 5.0 V -	T _C = 25 °C	- I _D	8.0			
		$T_{C} = 25 \text{ °C}$ $T_{C} = 100 \text{ °C}$		5.7	A		
Pulsed Drain Current ^a			I _{DM}	32			
Linear Derating Factor				0.18	W/°C		
Single Pulse Avalanche Energy ^b			E _{AS} 68		mJ		
Maximum Power Dissipation	T _C = 25 °C		PD	P _D 27			
Peak Diode Recovery dV/dt ^c			dV/dt	4.5	V/ns		
Operating Junction and Storage Temperature Range		T _J , T _{stg}	- 55 to + 175				
Soldering Recommendations (Peak Temperature)	for 10 s			300 ^d			
Mounting Torque	6-32 or M3 screw			10	lbf ⋅ in		
				1.1	N · m		

Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11). b. V_{DD} = 25 V, starting T_J = 25 °C, L = 1.2 mH, R_G = 25 Ω , I_{AS} = 8.0 A (see fig. 12). c. I_{SD} ≤ 10 A, dI/dt ≤ 90 Å/µs, V_{DD} ≤ V_{DS}, T_J ≤ 175 °C.

d. 1.6 mm from case.

* Pb containing terminations are not RoHS compliant, exemptions may apply

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THERMAL RESISTANCE RA	TINGS							
PARAMETER	SYMBOL	TYP. MAX.			UNIT			
Maximum Junction-to-Ambient	R _{thJA}	- 65 - 5.5				°C ///		
Maximum Junction-to-Case (Drain)	R _{thJC}				°C/W			
SPECIFICATIONS $T_J = 25 \ ^{\circ}C$,		vise noted			1	1	1	
PARAMETER	SYMBOL	TES	T CONDITI	ONS	MIN.	TYP.	MAX.	UNIT
Static						•		
Drain-Source Breakdown Voltage	V _{DS}	V _{GS} =	= 0 V, I _D = 2	50 µA	60	-	-	V
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Reference	e to 25 °C,	I _D = 1 mA	-	0.070	-	V/°C
Gate-Source Threshold Voltage	V _{GS(th)}	V _{DS} =	= V _{GS} , I _D = 2	250 μΑ	1.0	-	2.0	V
Gate-Source Leakage	I _{GSS}	V _{GS} = ± 10 V			-	-	± 100	nA
Zava Cata Valtaga Drain Current	1	V _{DS} =	= 60 V, V _{GS}	= 0 V	-	-	25	
Zero Gate Voltage Drain Current	IDSS	V _{DS} = 48 V, V _{GS} = 0 V, T _J = 150 °C			-	-	250	μA
Drain-Source On-State Resistance	_	V _{GS} = 5.0 V	I _D	= 4.8 A ^b	-	-	0.20	-
	R _{DS(on)}	V _{GS} = 4.0 V	I _D	= 4.0 A ^b	-	-	0.28	Ω
Forward Transconductance	g _{fs}	V _{DS} = 25 V, I _D = 4.8 A ^b		3.6	-	-	S	
Dynamic						•		1
Input Capacitance	C _{iss}		<u> </u>		-	400	-	
Output Capacitance	C _{oss}	-	$V_{GS} = 0 V,$ $V_{DS} = 25 V,$		-	170	-	
Reverse Transfer Capacitance	C _{rss}	f = 1.0 MHz, see fig. 5 f = 1.0 MHz		-	42	-	pF	
Drain to Sink Capacitance	C			2	-	12	-	
Total Gate Charge	Qg			-	-	8.4		
Gate-Source Charge	Q _{gs}	V _{GS} = 5.0 V	$I_{\rm D} = 10$ Å	10 A, $V_{DS} = 48 V$,	-	-	3.5	nC
Gate-Drain Charge	Q _{gd}	$v_{GS} = 5.0$ v see fig. 6 and 13 ^b		J. 6 and 13 ⁵	-	-	6.0	
Turn-On Delay Time	t _{d(on)}				-	9.3	-	
Rise Time	t _r		= 30 V, I _D =		-	110	-	
Turn-Off Delay Time	t _{d(off)}	$R_G = 12 \Omega$, $R_D = 2.8 \Omega$, see fig. 10^b		_	17	_	ns	
Fall Time	t _f			_	26	-		
Internal Drain Inductance	L _D	Between lead, 6 mm (0.25") from package and center of die contact		_	4.5	_	nH	
Internal Source Inductance	L _S			-	7.5	-		
Drain-Source Body Diode Characteristic	s						-	-
Continuous Source-Drain Diode Current	I _S	MOSFET symbol showing the		-	-	8.0	A	
Pulsed Diode Forward Current ^a	I _{SM}	integral reverse p - n junction diode			-	-		32
Body Diode Voltage	V _{SD}	$T_{J} = 25 \text{ °C}, I_{S} = 8.0 \text{ A}, V_{GS} = 0 \text{ V}^{b}$			-	-	1.6	V
Body Diode Reverse Recovery Time	t _{rr}	$T_J = 25 \text{ °C}, I_F = 10 \text{ A}, dl/dt = 100 \text{ A/}\mu\text{s}^b$		-	65	130	ns	
Body Diode Reverse Recovery Charge	Q _{rr}			-	0.33	0.65	μC	
Forward Turn-On Time	t _{on}	Intrinsic turn-on time is negligible (turn-on is dominated by L_S and L_D)						_n)

Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).

b. Pulse width \leq 300 $\mu s;$ duty cycle \leq 2 %.



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TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

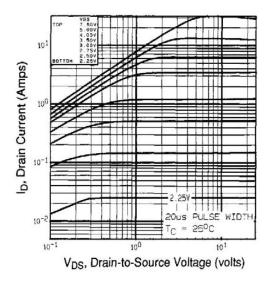


Fig. 1 - Typical Output Characteristics, $T_C = 25 \ ^{\circ}C$

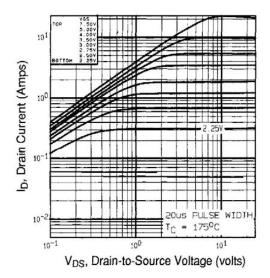


Fig. 2 - Typical Output Characteristics, $T_C{=}$ 175 $^\circ C$

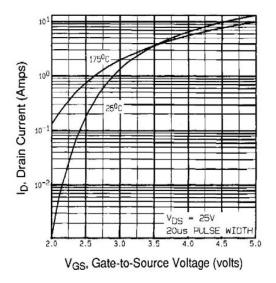


Fig. 3 - Typical Transfer Characteristics

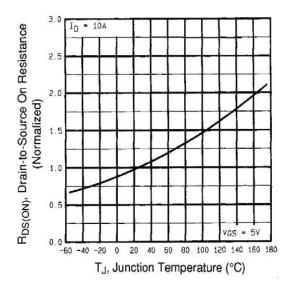


Fig. 4 - Normalized On-Resistance vs. Temperature

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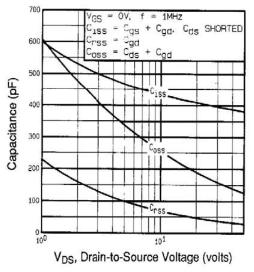


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

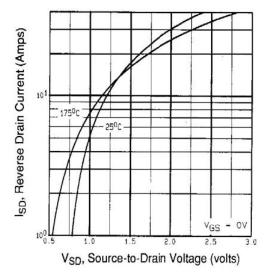


Fig. 7 - Typical Source-Drain Diode Forward Voltage

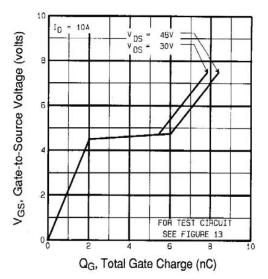
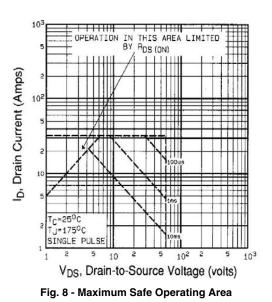


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage





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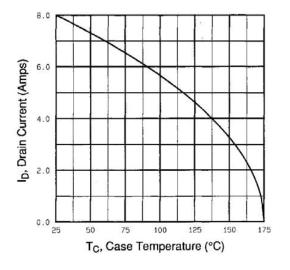


Fig. 9 - Maximum Drain Current vs. Case Temperature

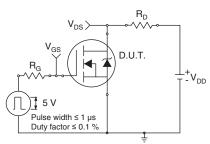


Fig. 10a - Switching Time Test Circuit

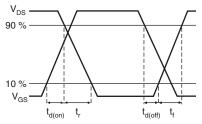


Fig. 10b - Switching Time Waveforms

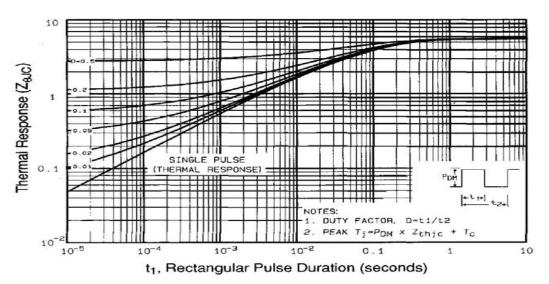


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case

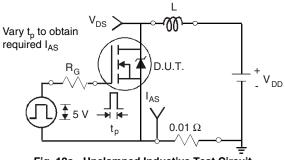


Fig. 12a - Unclamped Inductive Test Circuit

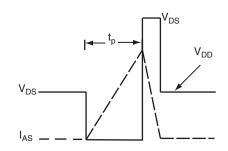
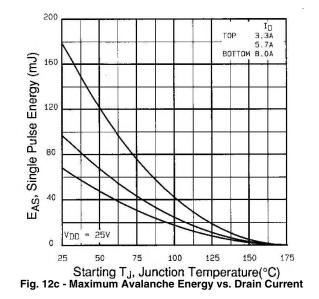
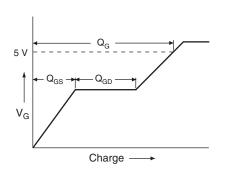


Fig. 12b - Unclamped Inductive Waveforms

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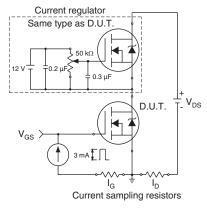
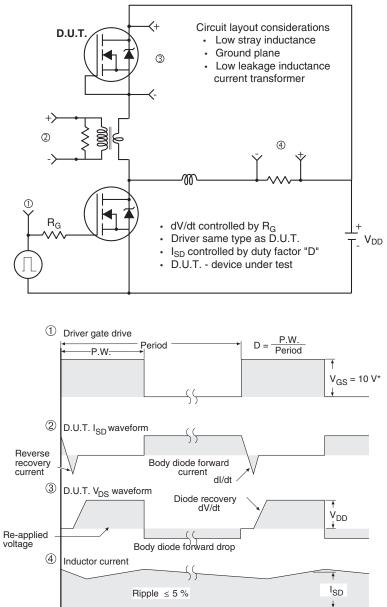


Fig. 13b - Gate Charge Test Circuit



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Peak Diode Recovery dV/dt Test Circuit

* V_{GS} = 5 V for logic level devices and 3 V drive devices

Fig. 14 - For N-Channel

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